



# *Accredited Laboratory*

A2LA has accredited

**CAL-RITE CORPORATION**

*Naperville, IL*

for technical competence in the field of

**Calibration**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 7<sup>th</sup> day of September 2022.

A blue ink signature of a person, likely a representative of the Accreditation Council, written over a horizontal line.

Vice President, Accreditation Services  
For the Accreditation Council  
Certificate Number 866.01  
Valid to October 31, 2024

*For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.*



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017  
& ANSI/NCSL Z540-1-1994

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CALIBRATION

Valid To: October 31, 2024

Certificate Number: 0866.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1, 7</sup>:

I. Dimensional

Parameter/Equipment	Range	CMC <sup>2, 5, 8</sup> (±)	Comments
Calipers <sup>3</sup>	Up to 6 in (> 6 to 20) in (> 20 to 60) in	(69 + 0.6R) μin (200 + 0.6R) μin (460 + 0.6R) μin	Gage blocks
Displacement Length Indicators <sup>3</sup> – (Drop, Test and LVDT)	Up to 4 in (> 4 to 12) in	7L + 29 μin 12L + 20 μin	Gage blocks, digital micrometer head
Extensometers/COD Gage/Deflectometers <sup>3</sup>			ASTM E83 and ISO 9513;
Gage Lengths 2 in and Below	Up to 0.02 in (> 0.02 to 2.0) in	14 μin 18 μin	Gage blocks, extensometer calibrator; uncertainties listed in displacement
Gage Lengths (> 2 to 25) in	(> 2 to 25) in	70L + 35 μin	Gage blocks
Gage Length	Up to 8 in	0.0013 in	Caliper
Micrometers <sup>3</sup> –	Up to 6 in (> 6 to 20) in	(69 + 0.6R) μin (200 + 0.6R) μin	Gage blocks

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Microscopes <sup>3</sup> – Displacement	Up to 1 in  Up to 25.4 mm	57 µin  1.7 µm	ASTM E1951 stage micrometers

## II. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC <sup>2, 4, 5, 6</sup> (±)	Comments
DC Voltage – Generate, Electrical Calibration of Load Indicators	± (0 to 4.4) mV/V	0.000 14 mV/V	Precision simulator
Electrical Simulation of Thermocouple Indicating Devices	Type E (-250 to 1000) °C Type J (-210 to 1200) °C Type K (-270 to 1372) °C Type N (-200 to 1300) °C Type T (-250 to 400) °C	0.70 °C 0.70 °C 0.70 °C 0.70 °C 0.70 °C	Fluke 743B
Alignment System Calibration	100 µε 500 µε 1000 µε 2000 µε 3000 µε	1.4 µε 1.5 µε 1.6 µε 1.9 µε 2.2 µε	Strain indicator calibrator

### III. Mechanical

Parameter/Equipment	Range	CMC <sup>2, 4, 5, 9</sup> ( $\pm$ )	Comments
Scales and Balances <sup>3</sup>	(1 to 200) mg	0.012 mg	Class 1
	300 mg	0.012 mg	
	500 mg	0.012 mg	
	1 g to 20 kg	0.029 %	Certified weights
	(0.001 to 0.1) lb	0.029 %	
	(> 0.1 to 2) lb	0.029 %	
	(> 2 to 600) lb	0.029 %	
Mass – Measure	(1 to 200) mg	0.016 mg	Mass comparator, mass standards
	300 mg	0.026 mg	
	500 mg	0.026 mg	
	1 g	0.027 mg	
	2 g	0.027 mg	
	3 g	0.029 mg	
	5 g	0.030 mg	
	10 g	0.037 mg	
	20 g	0.043 mg	
	30 g	0.068 mg	
	50 g	0.071 mg	
	100 g	0.12 mg	
	200 g	0.21 mg	
	205 g	0.22 mg	
	300 g	0.60 mg	
	500 g	0.58 mg	
	1 kg	1.8 mg	
	2 kg	6.7 mg	
	3 kg	6.0 mg	
	5 kg	9.5 mg	
	5.1 kg	9.5 mg	
	10 kg	47 mg	
	11.8 kg	47 mg	
	20 kg	50 mg	
	25 kg	55 mg	
	30 kg	120 mg	
	32.1 kg	120 mg	

Parameter/Equipment	Range	CMC <sup>2, 4, 5, 9</sup> (±)	Comments
Force <sup>3</sup> – Measure			
Tension and Compression by Deadweight w/ Local Gravity and Air Bouyancy Corrections	(0.01 to 20) lbf	0.04 %	ASTM E4 and ISO 7500-1
Comparison to Load Cell in Compression	(1 to 1 000 000) lbf	0.25 %	ASTM E4 within the Class A working range
Comparison to Load Cell in Tension	(1 to 250 000) lbf	0.25 %	ISO 7500-1 within the Class 1 working range
Force3 – Measuring Equipment (Tension and Compression)			Force calibrations include:
Calibration by Deadweight w/ Local Gravity and Air Buoyancy Corrections	(10 to 1000) lbf	0.05 %	
Comparison to Load Cell in Compression/Tension	(10 to 1 000) lbf (1000 to 10 000) lbf (10 000 to 100 000) lbf	0.05 % 0.01 % 0.01 %	ASTM E74 within Class AA working range
Comparison to Load Cell in Compression/Tension	(10 to 1 000) lbf (1000 to 10 000) lbf (10 000 to 100 000) lbf	0.05 % 0.04 % 0.04 %	ISO 376 within Class 00, 0.5, and 1 working ranges

Parameter/Equipment	Range	CMC <sup>2, 4, 5</sup> ( $\pm$ )	Comments
Verification of Test Frames <sup>3</sup> –			
Specimen Alignment (50 to 10 000) lbf	(100 to 3000) $\mu$ e	1.0 % + 5 $\mu$ e	ASTM E1012 alignment calibration system
Crosshead Displacement	(0 to 2) in (2 to 25) in	250 $\mu$ in 0.23 %	ASTM E2309 digital indicator cable extension transducer
Crosshead Speed	(0.005 to 20) in/min	0.33 %	ASTM E2658 cable extension transducer with stopwatch
Strain Rate	(0.0005 to 0.015) in/in/min	0.00012 in/in/min	Calibrated extensometer within ASTM Class B1 range and stopwatch
Load Rate	(50 to 600 000) lb/min	0.35 %	Class A Load cell and stopwatch
Pressure Gauges <sup>3</sup>	(0 to 3000) psi	0.54 psi	Pressure calibrator

Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Hardness Testers <sup>3</sup> – Rockwell	HRA: (20 to 65) HRA (70 to 78) HRA (80 to 84) HRA  HRBW: (40 to 59) HRBW (60 to 79) HRBW (80 to 100) HRBW  HRC: (20 to 30) HRC (35 to 55) HRC (60 to 65) HRC  HREW: (70 to 79) HREW (84 to 90) HREW (93 to 100) HREW  HRFW: (60 to 75) HRFW (80 to 90) HRFW (94 to 100) HRFW  HRGW: (30 to 50) HRGW (55 to 75) HRGW (80 to 94) HRGW  HRHW: (80 to 94) HRHW (94 to 100)HRHW  HRKW: (40 to 60) HRKW (65 to 80) HRKW (85 to 100) HRKW  HRMW: Low High	0.44 HRA 0.34 HRA 0.27 HRA  0.69 HRBW 0.58 HRBW 0.60 HRBW  0.41 HRC 0.40 HRC 0.36 HRC  0.55 HREW 0.61 HREW 0.53 HREW  0.52 HRFW 0.51 HRFW 0.59 HRFW  0.60 HRGW 0.49 HRGW 0.49 HRGW  0.59 HRHW 0.44 HRHW  0.54 HRKW 0.62 HRKW 0.47 HRKW  0.55 HRMW 0.44 HRMW	Indirect verification per ASTM E18





Parameter/Equipment	Range	CMC <sup>2</sup> (±)	Comments
Hardness Testers <sup>3</sup> – Rockwell (cont)	HR15YW: Low High  HR15TS: (74 to 80) HR15TS (81 to 86) HR15TS (87 to 93) HR15TS  HR30TS: (43 to 56) HR30TS (57 to 69) HR30TS (70 to 83) HR30TS  HRBS: (40 to 59) HR30BS (60 to 79) HR30BS (80 to 100) HR30BS	0.52 HR15YW 0.52 HR15YW  0.61 HR15TS 0.61 HR15TS 0.41 HR15TS  0.50 HR30TS 0.44 HR30TS 0.43 HR30TS  0.71 HRBS 0.69 HRBS 0.58 HRBS	Indirect verification per ASTM E18 rev- 05e1
Hardness Testers – Brinell			
HBW 10/3000/15	(95 to 650) HBW	6.5 HBW	Indirect verification method per ISO 6506-2, ASTM E10
HBW 10/3000/30	(96 to 650) HBW	7.3 HBW	
HBW 10/1500/15	(48 to 327) HBW	3.8 HBW	
HBW 10/1000/10	(32 to 218) HBW	2.0 HBW	
HBW 5/750/30	(96 to 650) HBW	9.6 HBW	
HBW 10/500/5	(16 to 109) HBW	1.9 HBW	
HBW 2.5/187.5/30	(96 to 650) HBW	9.9 HBW	
HBW 2.5/62.5/10	(32 to 218) HBW	6.3 HBW	

Parameter/Equipment	Range	CMC <sup>2, 4</sup> (±)	Comments
Hardness Testers – Brinell (cont)			Indirect verification method per ISO 6506-2, ASTM E10
Direct Verification of Brinell Hardness Testers			
Direct Verification of the Test Force	(62.5, 187.5, 500, 750, 1000, 1500, 3000) kgf	0.25 %	Load cells within ASTM E4 Class A working range
Verification of the Brinell Scope <sup>5</sup>	(0 to 10) mm Type A and Type B	1.5 µm	Stage micrometer
Verification of Test Cycle	Up to 15 sec	0.08 sec	Stopwatch
Leeb Hardness Testers <sup>3</sup>	759 HLD	9.6 HLD	ASTM A956
Microindentation Hardness Testers (Knoop and Vickers) <sup>3</sup> –			
For Loads Less than 1000 g	(100 to 250) HK (250 to 650) HK > 650 HK	1.0 % HK 1.0 % HK 1.0 % HK	Indirect verification method per ASTM E384
	(100 to 240) HV (240 to 600) HV > 600 HV	0.8 % HV 0.9 % HV 0.9 % HV	
For Loads Greater than 1000 g	Low HV Mid HV High HV	1.3 % HV 1.3 % HV 1.3 % HV	
X-Y Stage	(0 to 1) inch (0 to 25.4) mm	65 µin 1.4 µm	Stage micrometer

Parameter/Equipment	Range	CMC <sup>2, 4, 5, 9</sup> (±)	Comments
Indirect Verification of Charpy Impact Testers <sup>3</sup>			
Specimen Evaluation	Low Energy Mid Energy High Energy	1.6 J 3.0 J 4.9 J	ISO 148-2
Specimen Temperature Bath Verification	-40 °C	0.48 °C	Precision thermometer
Direct Verification of Charpy Impact Testers <sup>3</sup>			
Anvil to Anvil – Measure	40 mm	0.042 mm	ASTM E23 and ISO 148-2 caliper and telescope gage
Center Strike – Measure	20 mm	0.61 mm	Caliper
Charpy Base Level	0°	0.14°	Precision level
Charpy Bolt Torque	(30 to 150) lbf*ft	5.1 %	Torque wrench

#### IV. Thermodynamics

Parameter/Equipment	Range	CMC <sup>2, 5, 9</sup> (±)	Comments
Temperature – Measure <sup>3</sup>	(-80 to 590) °C	0.09 °C	Fluke 1529 w/ 5628 PRT
	(0 to 1000) °C	1.0 °C	Fluke 743B w/ Type K TC
Humidity – Measure <sup>3</sup>	(11 to 95) % RH	0.86 % RH	Vaisala HMP77B

## V. Time & Frequency

Parameter/Equipment	Range	CMC <sup>2, 5</sup> ( $\pm$ )	Comments
Timers & Stopwatches <sup>3</sup>	(0 to 24) hrs	0.04 sec/24 hrs	Timometer

<sup>1</sup> This laboratory offers commercial calibration service and field calibration service.

<sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of  $k = 2$ . The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

<sup>3</sup> Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

<sup>4</sup> In the statement of CMC, percentages are percent of reading unless otherwise indicated.

<sup>5</sup> Uncertainties may differ depending on the performance of artifact being measured at the time of calibration and the resolution of the device under test.

<sup>6</sup> The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC's are expressed as either a specific value that covers the full range or as a percent or fraction of the reading plus a fixed floor specification.

<sup>7</sup> This scope meets A2LA's *P112 Flexible Scope Policy*.

<sup>8</sup> L is the numerical value of the nominal length of the device measured in inches, R is the resolution of the unit under test.

<sup>9</sup> The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.